



# Specification for Approval

Date: 2014/12/03

深圳台慶 Customer:

HPC3010 A-100M

TALTECH DAL

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**TAI-TECH Advanced Electronics Co., Ltd** 

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Mike Yang	Jack Chan	Sharon Ho

# Power Inductor

HPC3010A-100M

ECN HISTORY LIST						
DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN		
14/12/03	新 發 行	楊祥忠	詹偉特	何秦芝		
		DATE DESCRIPTION	DATE DESCRIPTION APPROVED	DATE DESCRIPTION APPROVED CHECKED		

### **Power Inductor**

HPC3010A-100M

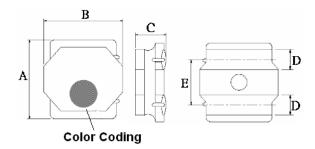
### 1. Features

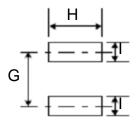
- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

# Halogen-free



### 2. Dimension





Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	G(mm)	H(mm)	l(mm)
HPC3010A	3.0±0.1	3.0±0.1	1.0 max.	0.9±0.2	1.9±0.2	2.2 ref.	2.7 ref.	0.8 ref.

Units: mm

### 3. Part Numbering

<b>HPC</b>	<b>3010</b>	A	-	100	M
Α	В	С		D	Ε

A: Series

**B**: Dimension

C: Control S/N

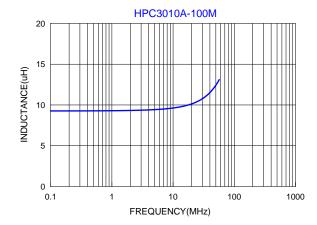
D: Inductance 100=10 ${\rm uH}$  E: Inductance Tolerance  ${\rm M=\pm20\%}$ 

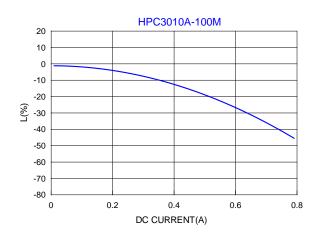
### 4. Specification

TAI-TECH Part Number	Inductance (uH)	Tolerance (%)	Test Frequency (Hz)	SRF (MHz) min.	DCR (Ω) ±20%	I sat (A)	I rms (A)	Color Coding
HPC3010A-100M	10	±20%	1V100K	34	0.350	0.60	0.62	Silver

Note:

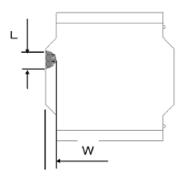
Irms : Based on temperature rise  $(\triangle T:40^{\circ}C\ \text{typ.})$ 





Core chipping

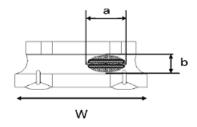
The appearance standard of the chipping size on top side, and bottom side ferrite core is listed below.



Туре	L	W
HPC3010A	0.6mm Max.	0.6mm Max.

Void appearance tolerance Limit

Size of voids occurring to coating resin is specified below.



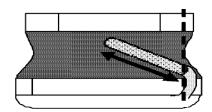
Exposed wire tolerance limit of coating resin part on product side.

Size of exposed wire occurring to coating resin is specified below.

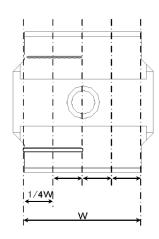
- 1. Width direction (dimension a): Acceptable when a  $\leq$  w/2 Nonconforming when a > w/2
- 2. Length direction (dimension b): Dimension b is not specified.
- 3. The total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, and is acceptable.

External appearance criterion for exposed wire

Exposed end of the winding wire at the secondary side should be 2mm and below.

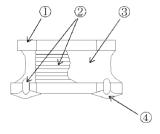


### 5. Exectrde appearance criterion for exposed wire



Cross section of joint part	Appearance judgment
Only top side of wire is exposed. (regardless of whole tope side of wire exposed)	Good
Wire is soldered insufficiently and less than half of outer diameter is covered with solder.	Less than one-quarter of width of insufficiently soldered portion shall be acceptable. (More than one-quarter shall be segregated as reject.)

### 6. Material List



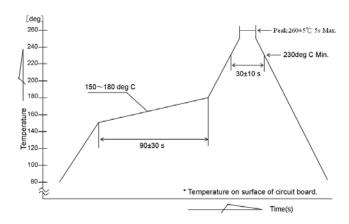
No.	Item	Material
1	Core	Ni-Zn ferrite
2	Wire	Copper Wire
3	Coating	Epoxy with magnetic
4	Solder	Lead free

### 7. Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125℃	
Storage temperature	-40~+125℃ (on board)	
Electrical Performance T	Test	
		HP4284A,CH11025,CH3302,CH1320,CH1320S
Inductance	Refer to standard electrical characteristics list.	LCR Meter.
DCR		CH16502,Agilent33420A Micro-Ohm Meter.
		Saturation DC Current (Isat) will cause L0
Saturation Current (Isat)	△L≦30% typical.	to drop $\triangle$ L(%)(keep quickly).
		Heat Rated Current (Irms) will cause the coil temperature rise
		$\triangle T(\mathbb{C})$ without core loss.
Heat Rated Current (Irms)	Approximately △T≤40°C	1.Applied the allowed DC current(keep 1 min.).
		2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test  Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles)  Temperature: 125±2°C (Bead)  Temperature: 85±2°C (Inductor)  Applied current: rated current  Duration: 1000±12hrs  Measured at room temperature after placing for 24±2 hrs  Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles  Humidity: 85±2*R.H.,  Temperature: 85°C±2°C  Duration: 1000hrs Min. with 100% rated current  Measured at room temperature after placing for 24±2 hrs
Thermal shock	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1: -40±2°C 30±5min Step2: 25±2°C ≤0.5min Step3: 105±2°C 30±5min Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time: 12 hours(20 minutes, 12 cycles each of 3 orientations).

Item	Performance	Test Condition					
Shock		Type Peak Normal Wave value duration (D) (g's) (ms) Wave form (Vi)ft/sec					
	Appearance : No damage.	SMD 1500 0.5 Half-sine 15.4					
	Inductance: within±10% of initial value  Q: Shall not exceed the specification value.	Lead 100 6 Half-sine 12.3					
Bending	RDC : within ±15% of initial value and shall not exceed the specification value	Shall be mounted on a FR4 substrate of the following dimensions: >=0805:40x100x1.2mm <0805:40x100x0.8mm Bending depth: >=0805:1.2mm <0805:0.8mm duration of 10 sec.					
Or de and We	More than 95% of the terminal electrode should	Preheat: 150°C,60sec.。 Solder: Sn99.5%-Cu0. 5%。 Temperature: 245±5°C。					
Soderability	be covered with solder。	Flux for lead free: Rosin. 9.5%。 Dip time: 4±1sec。 Depth: completely cover the termination					
		Number of heat cycles: 1					
Resistance to Soldering Heat		Temperature (°C) Time(s) Temperature ramp/immersion and emersion rate					
пеац		260 ±5(solder temp) 10 ±1 25mm/s ±6 mm/s					
Terminal Strength	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEI J-STD-020DClassification Reflow Profiles With the component mounted on a PCB with the device to tested, apply a force (>0805:1kg, <=0805:0.5kg)to the side of a device being test This force shall be applied for 60 +1 seconds. Also the force shall be applied for 60 +1 seconds. Also the force shall be applied for 60 to the component being tested.					

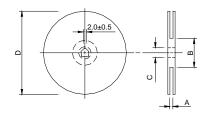
### 8. Soldering

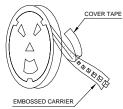


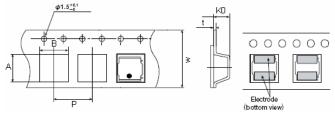
### 9. Packaging Information

#### (1) Reel Dimension

(2) Tape Dimension







Туре	A(mm)	B(mm)	C(mm)	D(mm)
HPC3010A	10±1.5	60±1.0	13±0.5	180±0.5

Туре	A(mm)	B(mm)	Ko(mm)	P(mm)	W(mm)	t(mm)
HPC3010A	3.2±0.1	3.2±0.1	1.4±0.1	4.0±0.1	8.0±0.2	0.30±0.05

#### (3) Packaging Quantity

Туре	Chip / Reel		
HPC3010A	2000		

#### **Application Notice**

• Storage Conditions(component level)

- To maintain the solderability of terminal electrodes: 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



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## 測試報告

號碼(No.) : CE/2014/B1174

日期(Date): 2014/11/17

頁数(Page): 1 of 15

# **Test Report**

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

(耀鑚科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

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以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

樣品名稱(Sample Description)

: SMD POWER INDUCTOR

樣品型號(Style/Item No.)

HPC(YHC, DR), MDC, FPC(YPC), FWP, SPC, SPI, UHP, DFP, DHP, TLPC, TLPH,

TLI SERIES

收件日期(Sample Receiving Date)

2014/11/10

測試期間(Testing Period)

: 2014/11/10 TO 2014/11/17

測試結果(Test Results) : 請見下一頁 (Please refer to next pages).



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號碼(No.): CE/2014/B1174 日期(Date): 2014/11/17

頁數(Page): 2 of 15

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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#### 測試結果(Test Results)

測試部位(PART NAME)No.1

: 整體混測 (MIXED ALL PARTS)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鎬 / Cadmium (Cd)	mg/kg	参考IEC 62321-5: 2013方法, 以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5: 2013 and performed by ICP-AES.	2	n.d.
鉛 / Lead (Pb)	mg/kg	参考IEC 62321-5: 2013方法,以感應耦合 電漿原子發射光譜儀檢測./With reference to IEC 62321-5: 2013 and performed by ICP-AES.	2	n.d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321-4: 2013方法, 以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-4: 2013 and performed by ICP-AES.	2	n.d.
六價鉻 / Hexavalent Chromium Cr(VI)	mg/kg	参考IEC 62321: 2008方法,以UV-VIS檢 測. / With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n.d.
绨 / Antimony (Sb)	mg/kg	參考US EPA 3052方法,以感應耦合電漿原子發射光譜儀檢測. / With reference to US EPA Method 3052. Analysis was performed by ICP-AES.	2	n.d.
鈹 / Beryllium (Be)	mg/kg	参考US EPA 3052方法,以感應耦合電漿原子發射光譜儀檢測./With reference to US EPA Method 3052. Analysis was performed by ICP-AES.	2	n.d.

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測試項目 (Test Items)	單位 (Unit) (Method)		方法偵測 極限値	結果 (Result)
(Test Trems)	(onit)	(wethod)	(MDL)	No.1
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	%	参考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
鄰苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	%	参考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761- 40-0; 68515-49-1)	%	参考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.01	n.d.
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553- 12-0; 68515-48-0)	%	参考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.01	n.d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n- octyl phthalate) (CAS No.: 117-84-0)	%	參考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	%	參考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
鄰苯二甲酸二異丁酯 / DIBP (Di- isobutyl phthalate) (CAS No.: 84-69- 5)	%	参考EN 14372, 以氣相層析/質譜儀檢測. / With reference to EN 14372. Analysis was performed by GC/MS.	0.003	n.d.
聚氯乙烯 / PVC	**	以紅外光譜分析及焰色法檢測./ Analysis was performed by FTIR and FLAME Test.	-	Negative

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result)
全氟辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	参考US EPA 3550C: 2007方法,以液相層析/質譜儀檢測./With reference to US EPA 3550C: 2007. Analysis was performed by LC/MS.	10	No.1
全氟辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	参考US EPA 3550C: 2007方法,以液相層析/質譜儀檢測. / With reference to US EPA 3550C: 2007. Analysis was performed by LC/MS.	10	n.d.
六溴環十二烷及所有主要被辨别出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified ( $\alpha$ - HBCDD, $\beta$ - HBCDD, $\gamma$ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	mg/kg	参考IEC 62321: 2008方法,以氣相層析/ 質譜儀檢測. / With reference to IEC 62321: 2008 method. Analysis was performed by GC/MS.	5	n.d.
鹵素 / Halogen			Y 27	
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n.d.
鹵素(氣) / Halogen-Chlorine (Cl) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582:2007, 以離子層析儀分析./ With reference to BS EN	50	n.d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	14582:2007. Analysis was performed by IC.	50	n.d.
鹵素(碘)/ Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg		50	n.d.

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號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁數(Page): 5 of 15

# **Test Report**

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(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値	結果 (Result)
多溴聯苯總和 / Sum of PBBs	,,		(MDL)	No.1
	mg/kg			n.d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n.d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n.d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n.d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n.d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n.d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n.d.
七溴聯苯 / Heptabromobiphenyl	mg/kg		5	n.d.
八溴聯苯 / Octabromobiphenyl	mg/kg		5	n.d.
九溴聯苯 / Nonabromobiphenyl	mg/kg		5	n.d.
十溴聯苯 / Decabromobiphenyl	mg/kg	參考IEC 62321: 2008方法,以氣相層析/ 質譜儀檢測./With reference to IEC 62321: 2008 and performed by GC/MS.	5	n.d.
多溴聯苯醚總和 / Sum of PBDEs	mg/kg		-	n.d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg		5	n.d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n.d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n.d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n.d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n.d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg		5	n.d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg		5	n.d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg		5	n.d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg		5	n.d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	n.d.

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號碼(No.): CE/2014/B1174 日期(Date): 2014/11/17

頁數(Page): 6 of 15

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#### 備註(Note):

- 1. mg/kg = ppm ; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限値)
- 4. "-" = Not Regulated (無規格値)
- 5. \*\*= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個别單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

PFOS参考資訊(Reference Information): 持久性有機污染物 POPs - (EU) 757/2010

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗 層材料中不得超過1ug/m2。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above lug/m2.)

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號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁数(Page): 7 of 15

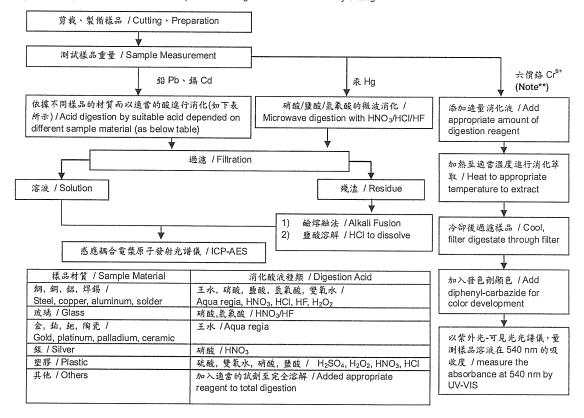
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- 1) 根據以下的流程圖之條件,樣品已完全溶解。( 六價發測試方法除外 ) / These samples were dissolved totally by pre-conditioning method according to below flow chart. ( Cr<sup>6+</sup> test method excluded )
- 2) 测試人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 3) 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



Note\*\*:(1) 針對非金屬材料加入鹼性消化液,加熱至 90~95℃萃取. / For non-metallic material, add alkaline digestion reagent and heat to 90~95℃.

(2) 針對金屬材料加入純水,加熱至沸騰萃取. / For metallic material, add pure water and heat to boiling.

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號碼(No.) : CE/2014/B1174 日期(Date) : 2014/11/17

頁數(Page): 8 of 15

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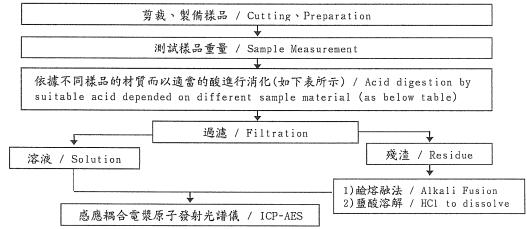
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- 1) 根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.
- 2) 測試人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 3) 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang

#### 元素以 ICP-AES 分析的消化流程圖

(Flow Chart of digestion for the elements analysis performed by ICP-AES)



鋼,銅,鋁,焊錫 / Steel, copper, aluminum, solder	王水,硝酸,鹽酸,氫氟酸,雙氧水 /
	Aqua regia, HNO3, HC1, HF, H2O2
玻璃 / Glass	硝酸,氫氟酸 / HNO3/HF
金,鉑,鲃,陶瓷 / Gold, platinum, palladium, ceramic	王水 / Aqua regia
銀 / Silver	硝酸 / HNO3
塑膠 / Plastic	硫酸,雙氧水,硝酸,鹽酸 / H2SO4, H2O2, HNO3, HC1
其他 / Others	加入適當的試劑至完全溶解 / Added appropriate
	reagent to total digestion

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號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁數(Page): 9 of 15

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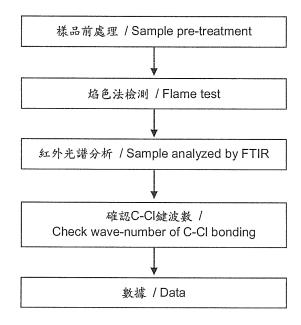
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#### 聚氯乙烯物質判定分析流程圖 /

#### Analysis flow chart for determination of PVC in material

- 測試人員:林建字 / Name of the person who made measurement: Roy Lin
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁數(Page): 10 of 15

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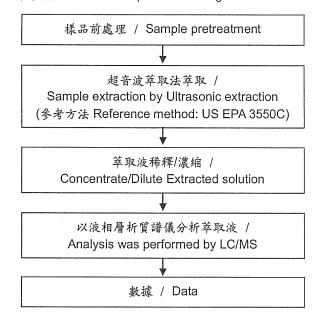
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### 全氟辛酸/全氟辛烷磺酸分析流程圖 / PFOA/PFOS analytical flow chart

- 測試人員:翁賜彬 / Name of the person who made measurement: Roman Wong
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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# **Test Report**

號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁数(Page): 11 of 15

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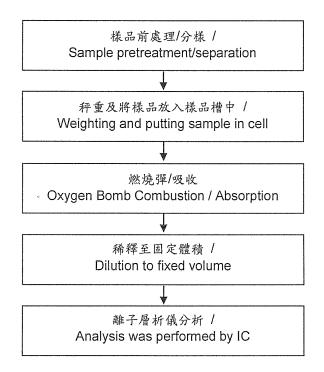
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#### 鹵素分析流程圖 / Analytical flow chart of halogen content

- 測試人員:陳恩臻 / Name of the person who made measurement: Rita Chen
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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號碼(No.) : CE/2014/B1174

日期(Date): 2014/11/17

頁数(Page): 12 of 15

# **Test Report**

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

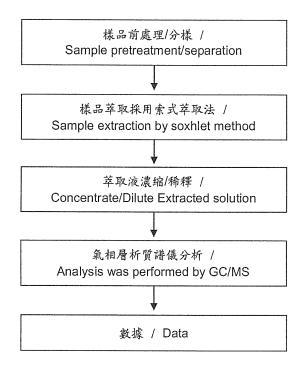
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#### 可塑劑分析流程圖 / Analytical flow chart of phthalate content

- 測試人員:翁賜彬 / Name of the person who made measurement: Roman Wong
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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頁數(Page): 13 of 15

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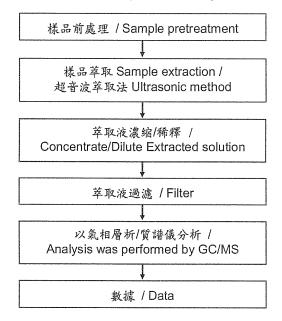
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### 六溴環十二烷分析流程圖 / HBCDD analytical flow chart

- 測試人員:翁賜彬 / Name of the person who made measurement; Roman Wong
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang



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號碼(No.): CE/2014/B1174

日期(Date): 2014/11/17

頁数(Page): 14 of 15

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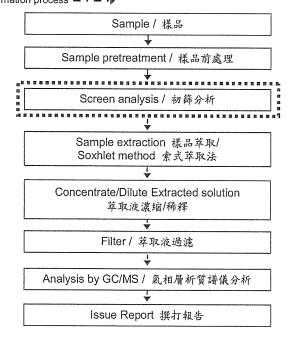
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### 多溴聯苯/多溴聯苯醚分析流程圖 / PBB/PBDE analytical FLOW CHART

- 🏿 測試人員:翁賜彬 / Name of the person who made measurement: Roman Wong
- 測試負責人:張啓興 / Name of the person in charge of measurement: Troy Chang

初次測試程序 / First testing process 選擇性篩檢程序 / Optional screen process \*\*\*\*

確認程序 / Confirmation process - · - · ▶



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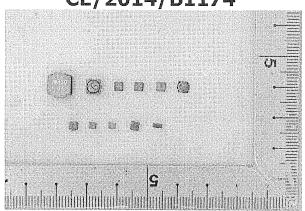
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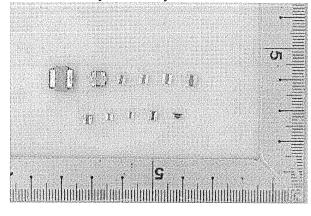
\* 照片中如有箭頭標示,則表示爲實際檢測之樣品/部位。\*

(The tested sample / part is marked by an arrow if it's shown on the photo.)

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\*\* 報告結尾 (End of Report) \*\*

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